

Application/Control No.	Applicant(s)/Patent under Reexamination
10/696,115	LOUI ET AL.
Examiner	Art Unit
Nancy Bitar	2624

SEARCHED					
Class	Subclass	Date	Examiner		
382	173,177,2 29,224,26 0,128,165,	7/15/2007	NB		
709	219	7/15/2007	NB		
375	240.1	7/15/2007	NB		
358	3.01	7/15/2007	NB		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
382	171,224	7/15/2007	NB	
BGPU	B tea	tsear	ch	
See	interg	forence	Scurch	
loss ~	tout		24	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Update East search	7/15/2007	NB		
NPL and IEEE search	7/15/2007	NB		
Consulted with Samir Ahmed	7/15/2007	NB		